

FEATURES

- Member of the Texas Instruments Widebus™ Family
- UBT™ Transceiver Combines D-Type Latches and D-Type Flip-Flops for Operation in Transparent, Latched, or Clocked Modes
- OEC™ Circuitry Improves Signal Integrity and Reduces Electromagnetic Interference
- Translates Between GTL/GTL+ Signal Level and LVTTTL Logic Levels
- High-Drive (100 mA), Low-Output-Impedance (12 Ω) Bus Transceiver (B Port)
- Edge-Rate-Control Input Configures the B-Port Output Rise and Fall Times
- I_{off} , Power-Up 3-State, and BIAS V_{CC} Support Live Insertion
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors on A Port
- Distributed V_{CC} and GND Pins Minimize High-Speed Switching Noise

DESCRIPTION/ORDERING INFORMATION

The SN74GTL1655 is a high-drive (100 mA), low-output-impedance (12 Ω) 16-bit UBT™ transceiver that provides LVTTTL-to-GTL/GTL+ and GTL/GTL+-to-LVTTTL signal-level translation. This device is partitioned as two 8-bit transceivers and combines D-type flip-flops and D-type latches to allow for transparent, latched, and clocked modes of data transfer similar to the '16501 function. This device provides an interface between cards operating at LVTTTL logic levels and a backplane operating at GTL/GTL+ signal levels. Higher-speed operation is a direct result of the reduced output swing (<1 V), reduced input threshold levels, and OEC™ circuitry. The high drive is suitable for driving double-terminated low-impedance backplanes using incident-wave switching.

The user has the flexibility of using this device at either GTL ($V_{TT} = 1.2$ V and $V_{REF} = 0.8$ V) or the preferred higher noise margin GTL+ ($V_{TT} = 1.5$ V and $V_{REF} = 1$ V) signal levels. GTL+ is the Texas Instruments derivative of the Gunning Transceiver Logic (GTL) JEDEC standard JESD 8-3. The B port normally operates at GTL or GTL+ signal levels, while the A-port and control inputs are compatible with LVTTTL logic levels, but are not 5-V tolerant. V_{REF} is the reference input voltage for the B port.

DGG PACKAGE
(TOP VIEW)

| | | | |
|----------|----|----|---------------|
| 1OEAB | 1 | 64 | CLK |
| 1OEBA | 2 | 63 | 1LEAB |
| V_{CC} | 3 | 62 | 1LEBA |
| 1A1 | 4 | 61 | V_{ERC} |
| GND | 5 | 60 | GND |
| 1A2 | 6 | 59 | 1B1 |
| 1A3 | 7 | 58 | 1B2 |
| GND | 8 | 57 | GND |
| 1A4 | 9 | 56 | 1B3 |
| GND | 10 | 55 | 1B4 |
| 1A5 | 11 | 54 | 1B5 |
| GND | 12 | 53 | GND |
| 1A6 | 13 | 52 | 1B6 |
| 1A7 | 14 | 51 | 1B7 |
| V_{CC} | 15 | 50 | V_{CC} |
| 1A8 | 16 | 49 | 1B8 |
| 2A1 | 17 | 48 | 2B1 |
| GND | 18 | 47 | GND |
| 2A2 | 19 | 46 | 2B2 |
| 2A3 | 20 | 45 | 2B3 |
| GND | 21 | 44 | GND |
| 2A4 | 22 | 43 | 2B4 |
| 2A5 | 23 | 42 | 2B5 |
| GND | 24 | 41 | V_{REF} |
| 2A6 | 25 | 40 | 2B6 |
| GND | 26 | 39 | GND |
| 2A7 | 27 | 38 | 2B7 |
| V_{CC} | 28 | 37 | 2B8 |
| 2A8 | 29 | 36 | BIAS V_{CC} |
| GND | 30 | 35 | 2LEAB |
| 2OEAB | 31 | 34 | 2LEBA |
| 2OEBA | 32 | 33 | OE |



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SN74GTL1655

16-BIT LVTTL-TO-GTL/GTL+ UNIVERSAL BUS TRANSCEIVER WITH LIVE INSERTION

SCBS696I–JULY 1997–REVISED APRIL 2005



DESCRIPTION/ORDERING INFORMATION (CONTINUED)

This device is partitioned uniquely as two 8-bit transceivers with individual latch timing and output signals, but with a common clock and output enable inputs for both transceiver words.

Data flow for each word is determined by the respective latch enables (LEAB and LEBA), output enables (\overline{OEAB} and \overline{OEBA}), and clock (CLK). The output enables ($1\overline{OEAB}$, $1\overline{OEBA}$, $2\overline{OEAB}$, and $2\overline{OEBA}$) control byte 1 and byte 2 data for the A-to-B and B-to-A directions, respectively.

For A-to-B data flow, the devices operate in the transparent mode when LEAB is high. When LEAB transitions low, the A data is latched independent of CLK high or low. If LEAB is low, the A data is registered on the CLK low-to-high transition. When \overline{OEAB} is low, the outputs are active. With \overline{OEAB} high, the outputs are in the high-impedance state.

Data flow for the B-to-A direction is identical, but uses \overline{OEBA} , LEBA, and CLK. Note that CLK is common to both directions and both 8-bit words. \overline{OE} also is common and is used to disable all I/O ports simultaneously.

The SN74GTL1655 has adjustable edge-rate control (V_{ERC}). Changing V_{ERC} input voltage between GND and V_{CC} adjusts the B-port output rise and fall times. This allows the designer to optimize for various loading conditions.

This device is fully specified for live-insertion applications using I_{off} , power-up 3-state, and BIAS V_{CC} . The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down. The power-up 3-state circuitry places the outputs in the high-impedance state during power up and power down, which prevents driver conflict. The BIAS V_{CC} circuitry precharges and preconditions the B-port input/output connections, preventing disturbance of active data on the backplane during card insertion or removal, and permits true live-insertion capability.

When V_{CC} is between 0 and 1.5 V, the device is in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 1.5 V, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

Active bus-hold circuitry holds unused or undriven LVTTL inputs at a valid logic state. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.

ORDERING INFORMATION

| T_A | PACKAGE ⁽¹⁾ | | ORDERABLE PART NUMBER | TOP-SIDE MARKING |
|---------------|------------------------|---------------|-----------------------|------------------|
| –40°C to 85°C | TSSOP – DGG | Tape and reel | SN74GTL1655DGGR | GTL1655 |

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLES

FUNCTION⁽¹⁾

| INPUTS | | | | OUTPUT B | MODE |
|-------------------|------|-----|---|-------------------------------|----------------|
| \overline{OEAB} | LEAB | CLK | A | | |
| H | X | X | X | Z | Isolation |
| L | H | X | L | L | Transparent |
| L | H | X | H | H | Transparent |
| L | L | ↑ | L | L | Registered |
| L | L | ↑ | H | H | Registered |
| L | L | H | X | B ₀ ⁽²⁾ | Previous state |
| L | L | L | X | B ₀ ⁽³⁾ | Previous state |

- (1) A-to-B data flow is shown. B-to-A flow is similar, but uses \overline{OEBA} , LEBA, and CLK.
 (2) Output level before the indicated steady-state input conditions were established, provided that CLK was high before LEAB went low
 (3) Output level before the indicated steady-state input conditions were established

OUTPUT ENABLE

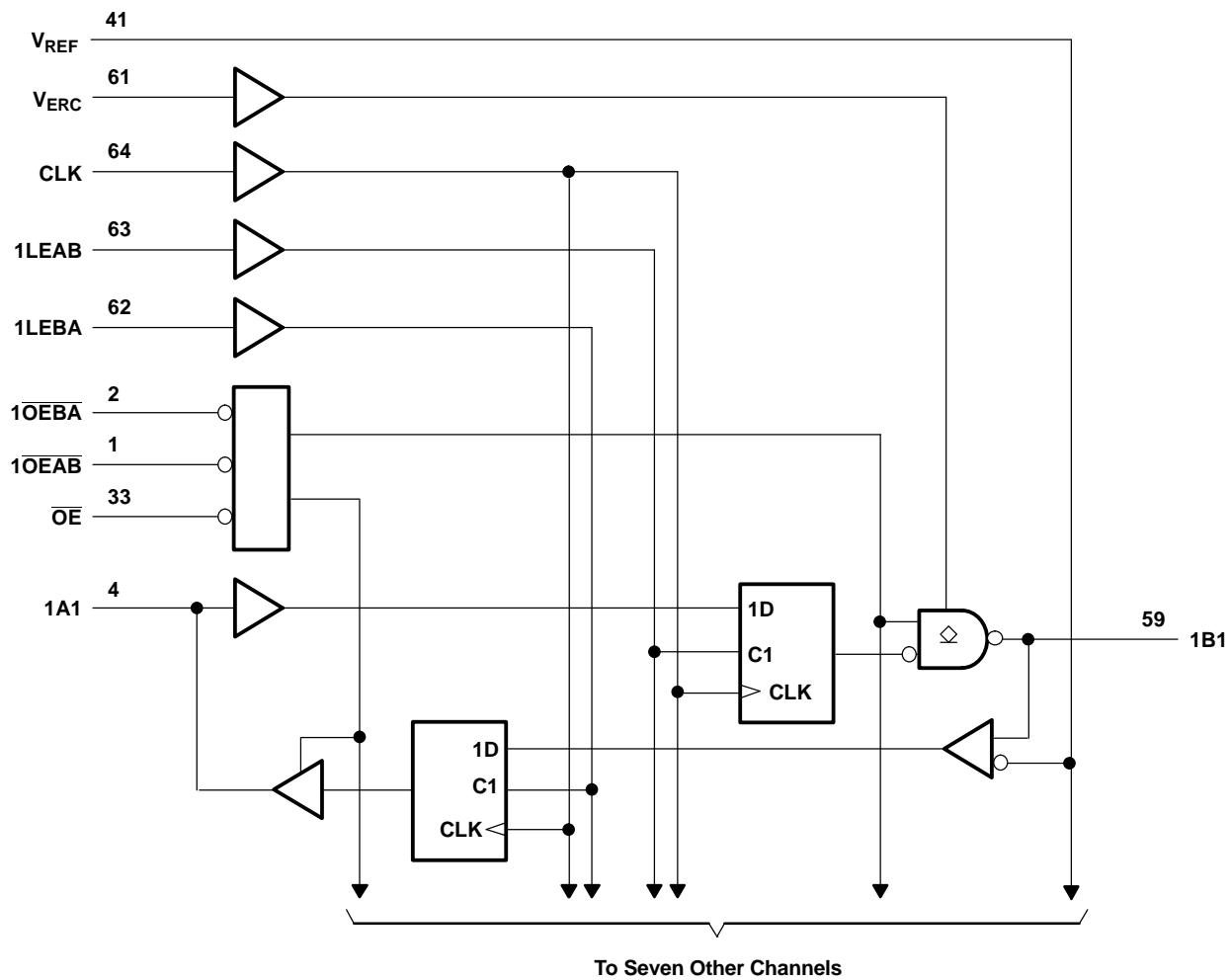
| INPUTS | | | OUTPUTS | |
|-----------------|-------------------|-------------------|---------|--------|
| \overline{OE} | \overline{OEAB} | \overline{OEBA} | A PORT | B PORT |
| L | L | L | Active | Active |
| L | L | H | Z | Active |
| L | H | L | Active | Z |
| L | H | H | Z | Z |
| H | X | X | Z | Z |

B-PORT EDGE-RATE CONTROL (V_{ERC})

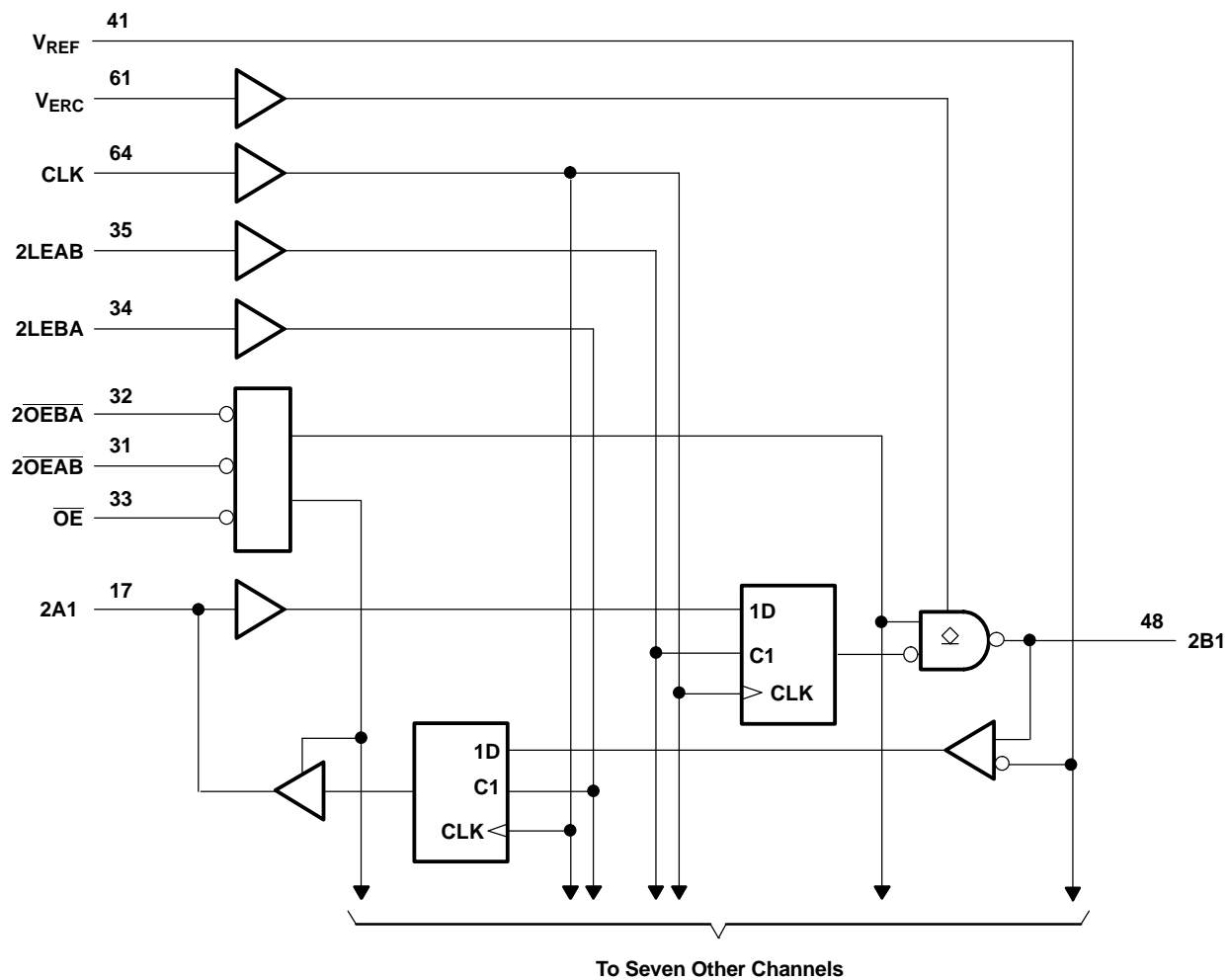
| input V _{ERC} | | OUTPUT B-PORT EDGE RATE |
|------------------------|--------------------|-------------------------------|
| LOGIC LEVEL | NOMINAL VOLTAGE | |
| H | V _{CC} | Slow |
| L | GND | Fast |

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LOGIC DIAGRAM (POSITIVE LOGIC)



LOGIC DIAGRAM (POSITIVE LOGIC) (CONTINUED)



SN74GTL1655

16-BIT LVTTTL-TO-GTL/GTL+ UNIVERSAL BUS TRANSCEIVER

WITH LIVE INSERTION

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Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

| | | MIN | MAX | UNIT |
|---------------------------|---|-----------------------------------|-----|----------|
| V_{CC} BIAS V_{CC} | Supply voltage range | –0.5 | 4.6 | V |
| V_I | Input voltage range ⁽²⁾ | A-port and control inputs | | –0.5 4.6 |
| | | B port, V_{ERC} , and V_{REF} | | –0.5 4.6 |
| V_O | Voltage range applied to any output in the high or power-off state ⁽²⁾ | A port | | –0.5 4.6 |
| | | B port | | –0.5 4.6 |
| I_O | Current into any output in the low state | A port | | 48 |
| | | B port | | 200 |
| I_O | Current into any A-port output in the high state ⁽³⁾ | | | 48 |
| | Continuous current through each V_{CC} or GND | | | ±100 |
| I_{IK} | Input clamp current | $V_I < 0$ | | –50 |
| I_{OK} | Output clamp current | $V_O < 0$ | | –50 |
| θ_{JA} | Package thermal impedance ⁽⁴⁾ | | | 55 |
| T_{stg} | Storage temperature range | –65 | 150 | °C |

- (1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
- (3) The current flows only when the output is in the high state and $V_O > V_{CC}$.
- (4) The package thermal impedance is calculated in accordance with JESD 51-7.

Recommended Operating Conditions⁽¹⁾⁽²⁾⁽³⁾⁽⁴⁾

| | | | MIN | NOM | MAX | UNIT | |
|--------------------------|--------------------------------|-----------------------|---------------------------|----------|------|-----------------|--------------------|
| BIAS V_{CC} | Supply voltage | | 3 | 3.3 | 3.6 | V | |
| V_{TT} | Termination voltage | GTL | 1.14 | 1.2 | 1.26 | V | |
| | | GTL+ | 1.35 | 1.5 | 1.65 | | |
| V_{REF} | Reference voltage | GTL | 0.74 | 0.8 | 0.87 | V | |
| | | GTL+ | 0.87 | 1 | 1.1 | | |
| V_I | Input voltage | B port | 0 | | | V_{TT} | V |
| | | Except B port | 0 | | | V_{CC} | |
| V_{IH} | High-level input voltage | B port | $V_{REF} + 50 \text{ mV}$ | | | V | |
| | | V_{ERC} | $V_{CC} - 0.6$ | V_{CC} | | | |
| | | Except B port and ERC | 2 | | | | |
| V_{IL} | Low-level input voltage | B port | $V_{REF} - 50 \text{ mV}$ | | | V | |
| | | V_{ERC} | GND | | | | 0.6 |
| | | Except B port and ERC | | | | | 0.8 |
| I_{IK} | Input clamp current | | -18 | | | mA | |
| I_{OH} | High-level output current | A port | -24 | | | mA | |
| I_{OL} | Low-level output current | A port | 24 | | | mA | |
| | | B port | 100 | | | | |
| $\Delta t/\Delta V_{CC}$ | Power-up ramp rate | | 200 | | | $\mu\text{s/V}$ | |
| T_A | Operating free-air temperature | | -40 | | | 85 | $^{\circ}\text{C}$ |

- (1) All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.
- (2) Normal connection sequence is GND first, BIAS $V_{CC} = 3.3 \text{ V}$ second, and $V_{CC} = 3.3 \text{ V}$, I/O, control inputs, V_{TT} and V_{REF} (any order) last. However, if the B-port I/O precharge is not required, the acceptable connection sequence is GND first and $V_{CC} = 3.3 \text{ V}$, BIAS $V_{CC} = 3.3 \text{ V}$, I/O, control inputs, V_{TT} and V_{REF} (any order) last. When V_{CC} is connected, the BIAS V_{CC} circuitry is disabled.
- (3) V_{TT} and R_{TT} can be adjusted to accommodate backplane impedances if the dc recommended I_{OL} ratings are not exceeded.
- (4) V_{REF} can be adjusted to optimize noise margins, but normally is two-thirds V_{TT} .

Electrical Characteristics

over recommended operating free-air temperature range, $V_{REF} = 1\text{ V}$ and $V_{TT} = 1.5\text{ V}$ (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | | MIN | TYP ⁽¹⁾ | MAX | UNIT |
|-----------------------|----------------|--|--|----------------|--------------------|-----------|---------------|
| V_{IK} | | $V_{CC} = 3\text{ V}$, | $I_I = -18\text{ mA}$ | | | -1.2 | V |
| V_{OH} | A port | $V_{CC} = 3\text{ V to } 3.6\text{ V}$, | $I_{OH} = -100\text{ }\mu\text{A}$ | $V_{CC} - 0.2$ | | | V |
| | | $V_{CC} = 3\text{ V}$ | $I_{OH} = -12\text{ mA}$ | 2.4 | | | |
| | | | $I_{OH} = -24\text{ mA}$ | 2.2 | | | |
| V_{OL} | A port | $V_{CC} = 3\text{ V to } 3.6\text{ V}$, | $I_{OL} = 100\text{ }\mu\text{A}$ | | | 0.2 | V |
| | | $V_{CC} = 3\text{ V}$ | $I_{OL} = 12\text{ mA}$ | | | 0.4 | |
| | | | $I_{OL} = 24\text{ mA}$ | | | 0.55 | |
| | B port | $V_{CC} = 3\text{ V}$ | $I_{OL} = 40\text{ mA}$ | | | 0.2 | |
| | | | $I_{OL} = 80\text{ mA}$ | | | 0.4 | |
| | | | $I_{OL} = 100\text{ mA}$ | | | 0.5 | |
| I_I | Control inputs | $V_{CC} = 3.6\text{ V}$ | $V_I = V_{CC}$ or GND | | | ± 10 | μA |
| | B port | | $V_I = V_{TT}$ or GND | | | ± 10 | |
| I_{off} | | $V_{CC} = 0$, | V_I or $V_O = 0\text{ to } 3.6\text{ V}$ | | | ± 100 | μA |
| $I_{I(hold)}$ | A port | $V_{CC} = 3\text{ V}$ | $V_I = 0.8\text{ V}$ | 75 | | | μA |
| | | | $V_I = 2\text{ V}$ | -75 | | | |
| | | $V_{CC} = 3.6\text{ V}^{(2)}$, | $V_I = 0\text{ to } V_{CC}$ | | | ± 500 | |
| I_{OZH} | B port | $V_{CC} = 3.6\text{ V}$, | $V_O = 1.5\text{ V}$ | | | 10 | μA |
| I_{OZL} | B port | $V_{CC} = 3.6\text{ V}$, | $V_O = 0.4\text{ V}$ | | | -10 | μA |
| $I_{OZ}^{(3)}$ | A port | $V_{CC} = 3.6\text{ V}$, | $V_O = V_{CC}$ or GND | | | ± 10 | μA |
| I_{OZPU} | A port | $V_{CC} = 0\text{ to } 3.6\text{ V}$, $V_O = 0.5\text{ V to } 3\text{ V}$, $\overline{OE} = \text{low}$ | | | | ± 50 | μA |
| I_{OZPD} | A port | $V_{CC} = 3.6\text{ V to } 0$, $V_O = 0.5\text{ V to } 3\text{ V}$, $\overline{OE} = \text{low}$ | | | | ± 50 | μA |
| I_{CC} | A or B port | $V_{CC} = 3.6\text{ V}$, $I_O = 0$, $V_I = V_{CC}$ or GND | Outputs high | | | 80 | mA |
| | | | Outputs low | | | 80 | |
| | | | Outputs disabled | | | 80 | |
| $\Delta I_{CC}^{(4)}$ | Except B port | $V_{CC} = 3.6\text{ V}$, A-port or control inputs at V_{CC} or GND, One input at $V_{CC} - 0.6\text{ V}$ | | | | 1 | mA |
| C_i | Control inputs | $V_I = V_{CC}$ or 0 | | | 3 | 5 | pF |
| C_{io} | A port | $V_O = V_{CC}$ or 0 | | | 5 | 6 | pF |
| | B port | | | | 6 | 8 | |

(1) All typical values are at $V_{CC} = 3.3\text{ V}$, $T_A = 25^\circ\text{C}$.

(2) This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to another.

(3) For I/O ports, the parameter I_{OZ} includes the input leakage current.

(4) This is the increase in supply current for each input that is at the specified TTL voltage level rather than V_{CC} or GND.

Live-Insertion Specifications

over recommended operating free-air temperature range

| PARAMETER | | TEST CONDITIONS | | MIN | MAX | UNIT |
|---------------------------|--------|--|--|-----|-----|---------------|
| I_{CC} (BIAS V_{CC}) | | $V_{CC} = 0\text{ to } 3\text{ V}$ | V_O (B port) = 0 to 1.2 V, V_I (BIAS V_{CC}) = 3 V to 3.6 V | | 5 | mA |
| | | $V_{CC} = 3\text{ V to } 3.6\text{ V}$ | | | 10 | μA |
| V_O | B port | $V_{CC} = 0$, | V_I (BIAS V_{CC}) = 3.3 V | 1 | 1.2 | V |
| I_O | B port | $V_{CC} = 0$, | V_O (B port) = 0.4 V, V_I (BIAS V_{CC}) = 3 V to 3.6 V | -1 | | μA |
| | | $V_{CC} = 0\text{ to } 3.6\text{ V}$, | $\overline{OE} = 3.3\text{ V}$ | | 100 | |
| | | $V_{CC} = 0\text{ to } 1.5\text{ V}$, | $\overline{OE} = 0\text{ to } 3.3\text{ V}$ | | 100 | |

SN74GTL1655

16-BIT LVTTTL-TO-GTL/GTL+ UNIVERSAL BUS TRANSCEIVER

WITH LIVE INSERTION

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Timing Requirements

over recommended ranges of supply voltage and operating free-air temperature,
 $V_{TT} = 1.2\text{ V}$, $V_{REF} = 0.8\text{ V}$, and $V_{ERC} = V_{CC}$ or GND for GTL (unless otherwise noted)

| | | | MIN | MAX | UNIT |
|--------------------|-----------------|-----------------------------|-----------------|-----|------|
| f_{clock} | Clock frequency | | | 160 | MHz |
| t_w | Pulse duration | LE high | 3 | | ns |
| | | CLK high or low | 3 | | |
| t_{su} | Setup time | Data before CLK \uparrow | 2.7 | | ns |
| | | Data before LE \downarrow | CLK high | 2.8 | |
| | | | CLK low | 2.6 | |
| t_h | Hold time | Data after CLK \uparrow | 0.4 | | ns |
| | | Data after LE \downarrow | CLK high or low | 0.9 | |

A-to-B Switching Characteristics

over recommended ranges of supply voltage and operating free-air temperature,
 $V_{TT} = 1.2\text{ V}$, $V_{REF} = 0.8\text{ V}$, and $V_{ERC} = V_{CC}$ or GND for GTL (see Figure 1)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | MIN | TYP | MAX | UNIT |
|--------------------------|--|--|-----|-----|-----|------|
| f_{max} | | | 160 | | | MHz |
| t_{PLH} | A $V_{ERC} = V_{CC}$ | B | 3.1 | | 5.2 | ns |
| t_{PHL} | | | 2.6 | | 6.2 | |
| t_{PLH} | CLK $V_{ERC} = V_{CC}$ | B | 3.4 | | 5.5 | ns |
| t_{PHL} | | | 2.4 | | 5.8 | |
| t_{PLH} | LEAB $V_{ERC} = V_{CC}$ | B | 3.5 | | 5.8 | ns |
| t_{PHL} | | | 2.6 | | 6.4 | |
| t_{en} | $\overline{\text{OEAB}}$ or $\overline{\text{OE}}$ $V_{ERC} = V_{CC}$ | B | 3.3 | | 5.4 | ns |
| t_{dis} | | | 2.7 | | 5.9 | |
| t_{PLH} | A $V_{ERC} = \text{GND}$ | B | 2.3 | | 4.3 | ns |
| t_{PHL} | | | 1.9 | | 4.3 | |
| t_{PLH} | CLK $V_{ERC} = \text{GND}$ | B | 2.7 | | 4.8 | ns |
| t_{PHL} | | | 1.8 | | 4.3 | |
| t_{PLH} | LEAB $V_{ERC} = \text{GND}$ | B | 2.8 | | 4.9 | ns |
| t_{PHL} | | | 2 | | 4.8 | |
| t_{en} | $\overline{\text{OEAB}}$ or $\overline{\text{OE}}$ $V_{ERC} = \text{GND}$ | B | 2.5 | | 4.5 | ns |
| t_{dis} | | | 2 | | 4.2 | |
| t_r | $V_{ERC} = \text{GND}$ | Transition time, B outputs (0.6 V to 1 V) | | 0.6 | | ns |
| | $V_{ERC} = V_{CC}$ | | | 1.2 | | |
| t_f | $V_{ERC} = \text{GND}$ | Transition time, B outputs (1 V to 0.6 V) | | 1.1 | | ns |
| | $V_{ERC} = V_{CC}$ | | | 1.7 | | |
| $t_{\text{sk(o)}}^{(1)}$ | | Skew between drivers in the same package switching in the same direction | | | 1 | ns |
| $t_{\text{sk(o)}}^{(2)}$ | | Skew between drivers switching in any direction in the same package | | | 1 | ns |

(1) Skew values are applicable for through mode only.

(2) Skew values are applicable for CLK mode only, with all outputs switching simultaneously.

B-to-A Switching Characteristics

over recommended ranges of supply voltage and operating free-air temperature,
 $V_{TT} = 1.2\text{ V}$ and $V_{REF} = 0.8\text{ V}$ for GTL (see Figure 1)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | MIN | MAX | UNIT |
|-----------------------------------|---|----------------|-----|-----|------|
| f _{max} | | | 160 | | MHz |
| t _{PLH} | B | A | 1.8 | 4.7 | ns |
| t _{PHL} | | | 2.3 | 4.6 | |
| t _{PLH} | CLK | A | 1.6 | 4 | ns |
| t _{PHL} | | | 1.5 | 3.4 | |
| t _{PLH} | LEBA | A | 1.7 | 4 | ns |
| t _{PHL} | | | 1.4 | 3.5 | |
| t _{en} | \overline{OEBA} or \overline{OE} | A | 1.2 | 4.2 | ns |
| t _{dis} | | | 1.2 | 6.1 | |
| t _{sk(o)} ⁽¹⁾ | Skew between drivers in the same package switching in the same direction | | | 1 | ns |
| t _{sk(o)} ⁽²⁾ | Skew between drivers switching in any direction in the same package | | | 1 | ns |

(1) Skew values are applicable for through mode only.

(2) Skew values are applicable for CLK mode only, with all outputs switching simultaneously.

SN74GTL1655

16-BIT LVTTTL-TO-GTL/GTL+ UNIVERSAL BUS TRANSCEIVER

WITH LIVE INSERTION

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Timing Requirements

over recommended ranges of supply voltage and operating free-air temperature,
 $V_{TT} = 1.5\text{ V}$, $V_{REF} = 1\text{ V}$, and $V_{ERC} = V_{CC}$ or GND for GTL+ (unless otherwise noted)

| | | | MIN | MAX | UNIT |
|--------------------|-----------------|-----------------------------|-----------------|-----|------|
| f_{clock} | Clock frequency | | | 160 | MHz |
| t_w | Pulse duration | LE high | 3 | | ns |
| | | CLK high or low | 3 | | |
| t_{su} | Setup time | Data before CLK \uparrow | 2.7 | | ns |
| | | Data before LE \downarrow | CLK high | 2.8 | |
| | | | CLK low | 2.6 | |
| t_h | Hold time | Data after CLK \uparrow | 0.4 | | ns |
| | | Data after LE \downarrow | CLK high or low | 0.9 | |

A-to-B Switching Characteristics

over recommended ranges of supply voltage and operating free-air temperature,
 $V_{TT} = 1.5\text{ V}$, $V_{REF} = 1\text{ V}$, and $V_{ERC} = V_{CC}$ or GND for GTL+ (see Figure 1)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | MIN | TYP | MAX | UNIT |
|--------------------------|--|--|-----|-----|-----|------|
| f_{max} | | | 160 | | | MHz |
| t_{PLH} | A $V_{ERC} = V_{CC}$ | B | 3 | | 5.1 | ns |
| t_{PHL} | | | 2.9 | | 6.5 | |
| t_{PLH} | CLK $V_{ERC} = V_{CC}$ | B | 3.4 | | 5.4 | ns |
| t_{PHL} | | | 2.7 | | 6.2 | |
| t_{PLH} | LEAB $V_{ERC} = V_{CC}$ | B | 3.5 | | 5.7 | ns |
| t_{PHL} | | | 2.8 | | 6.7 | |
| t_{en} | $\overline{\text{OEAB}}$ $V_{ERC} = V_{CC}$ | B | 3.3 | | 5.4 | ns |
| t_{dis} | | | 3 | | 6.3 | |
| t_{en} | $\overline{\text{OE}}$ $V_{ERC} = V_{CC}$ | B | 3 | | 5.5 | ns |
| t_{dis} | | | 3.6 | | 5.8 | |
| t_{PLH} | A $V_{ERC} = \text{GND}$ | B | 2.3 | | 4.3 | ns |
| t_{PHL} | | | 2 | | 4.4 | |
| t_{PLH} | CLK $V_{ERC} = \text{GND}$ | B | 2.7 | | 4.8 | ns |
| t_{PHL} | | | 1.9 | | 4.5 | |
| t_{PLH} | LEAB $V_{ERC} = \text{GND}$ | B | 2.8 | | 4.9 | ns |
| t_{PHL} | | | 2.1 | | 4.9 | |
| t_{en} | $\overline{\text{OEAB}}$ $V_{ERC} = \text{GND}$ | B | 2.5 | | 4.5 | ns |
| t_{dis} | | | 2.1 | | 4.4 | |
| t_{en} | $\overline{\text{OE}}$ $V_{ERC} = \text{GND}$ | B | 2.5 | | 4.6 | ns |
| t_{dis} | | | 2.9 | | 4.9 | |
| t_r | $V_{ERC} = \text{GND}$ | Transition time, B outputs (0.6 V to 1.3 V) | | 0.9 | | ns |
| | $V_{ERC} = V_{CC}$ | | | 1.7 | | |
| t_f | $V_{ERC} = \text{GND}$ | Transition time, B outputs (1.3 V to 0.6 V) | | 1.6 | | ns |
| | $V_{ERC} = V_{CC}$ | | | 2.4 | | |
| $t_{\text{sk(o)}}^{(1)}$ | | Skew between drivers in the same package switching in the same direction | | | 1 | ns |
| $t_{\text{sk(o)}}^{(2)}$ | | Skew between drivers switching in any direction in the same package | | | 1 | ns |

(1) Skew values are applicable for through mode only.

(2) Skew values are applicable for CLK mode only, with all outputs switching simultaneously.

B-to-A Switching Characteristics

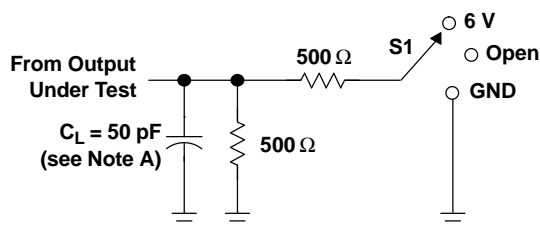
over recommended ranges of supply voltage and operating free-air temperature,
 $V_{TT} = 1.5\text{ V}$ and $V_{REF} = 1\text{ V}$ for GTL+ (see Figure 1)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | MIN | MAX | UNIT |
|-----------------------------------|---|----------------|-----|-----|------|
| f _{max} | | | 160 | | MHz |
| t _{PLH} | B | A | 2 | 4.8 | ns |
| t _{PHL} | | | 2.4 | 4.7 | |
| t _{PLH} | CLK | A | 1.6 | 4.4 | ns |
| t _{PHL} | | | 1.5 | 3.4 | |
| t _{PLH} | LEBA | A | 1.7 | 4 | ns |
| t _{PHL} | | | 1.4 | 3.5 | |
| t _{en} | OEBA | A | 1.2 | 4.2 | ns |
| t _{dis} | | | 1.2 | 6.1 | |
| t _{en} | OE | A | 1.2 | 4.7 | ns |
| t _{dis} | | | 1.2 | 6.3 | |
| t _{sk(o)} ⁽¹⁾ | Skew between drivers in the same package switching in the same direction | | 1 | | ns |
| t _{sk(o)} ⁽²⁾ | Skew between drivers switching in any direction in the same package | | 1 | | ns |

(1) Skew values are applicable for through mode only.

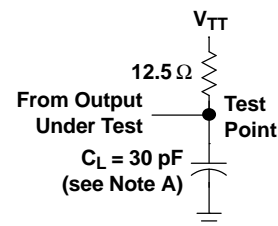
(2) Skew values are applicable for CLK mode only, with all outputs switching simultaneously.

PARAMETER MEASUREMENT INFORMATION

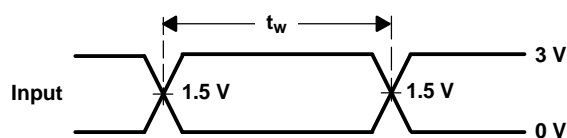


LOAD CIRCUIT FOR A OUTPUTS

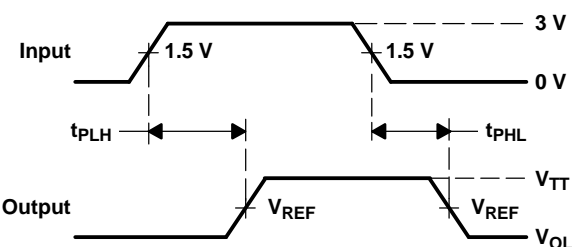
| TEST | S1 |
|-------------------|------|
| t_{PLH}/t_{PHL} | Open |
| t_{PLZ}/t_{PZL} | 6 V |
| t_{PHZ}/t_{PZH} | GND |



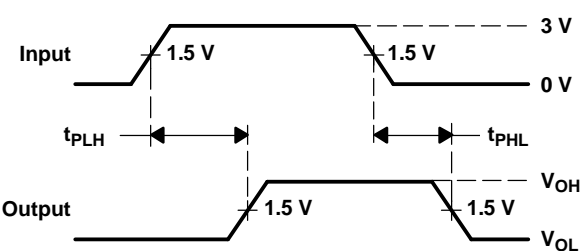
LOAD CIRCUIT FOR B OUTPUTS



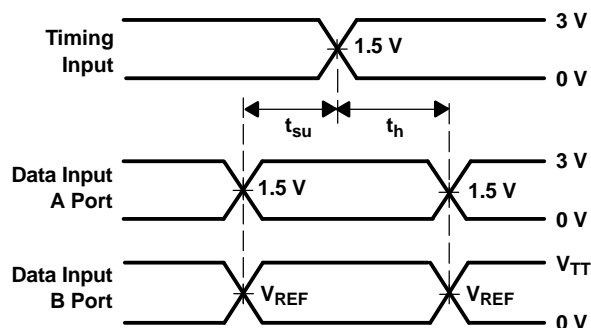
VOLTAGE WAVEFORMS
PULSE DURATION



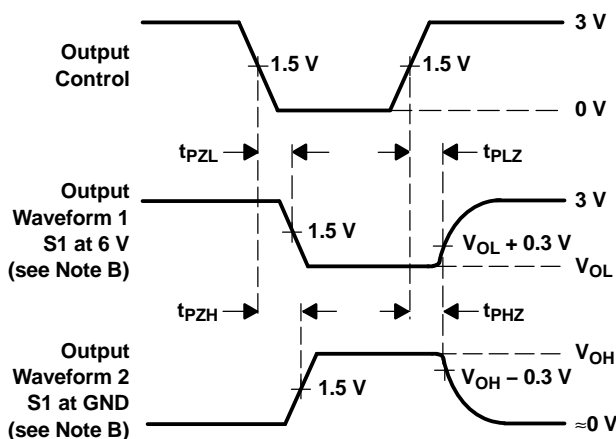
VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES
(CLK to B port)



VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES
(CLK to A port)



VOLTAGE WAVEFORMS
SETUP AND HOLD TIMES



VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES
(A port)

- NOTES:
- C_L includes probe and jig capacitance.
 - Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
 - All input pulses are supplied by generators having the following characteristics: $PRR \leq 10$ MHz, $Z_O = 50 \Omega$, $t_r \leq 2.5$ ns, $t_f \leq 2.5$ ns.
 - The outputs are measured one at a time, with one transition per measurement.
 - t_{PLZ} and t_{PHZ} are the same as t_{dis} .
 - t_{PZL} and t_{PZH} are the same as t_{en} .

Figure 1. Load Circuits and Voltage Waveforms

PACKAGING INFORMATION

| Orderable Device | Status ⁽¹⁾ | Package Type | Package Drawing | Pins | Package Qty | Eco Plan ⁽²⁾ | Lead/Ball Finish | MSL Peak Temp ⁽³⁾ |
|-------------------|-----------------------|--------------|-----------------|------|-------------|-------------------------|------------------|------------------------------|
| SN74GTL1655DGGR | ACTIVE | TSSOP | DGG | 64 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN74GTL1655DGGRE4 | ACTIVE | TSSOP | DGG | 64 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN74GTL1655DGGRG4 | ACTIVE | TSSOP | DGG | 64 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBsolete: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

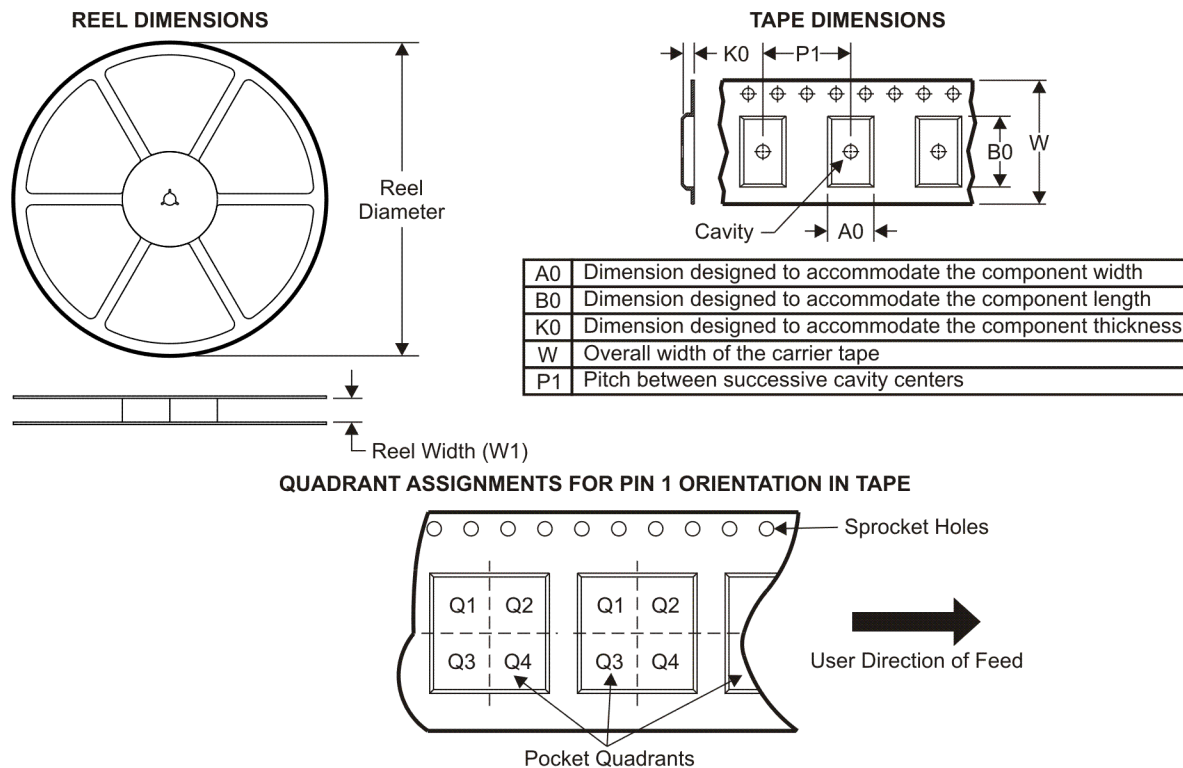
Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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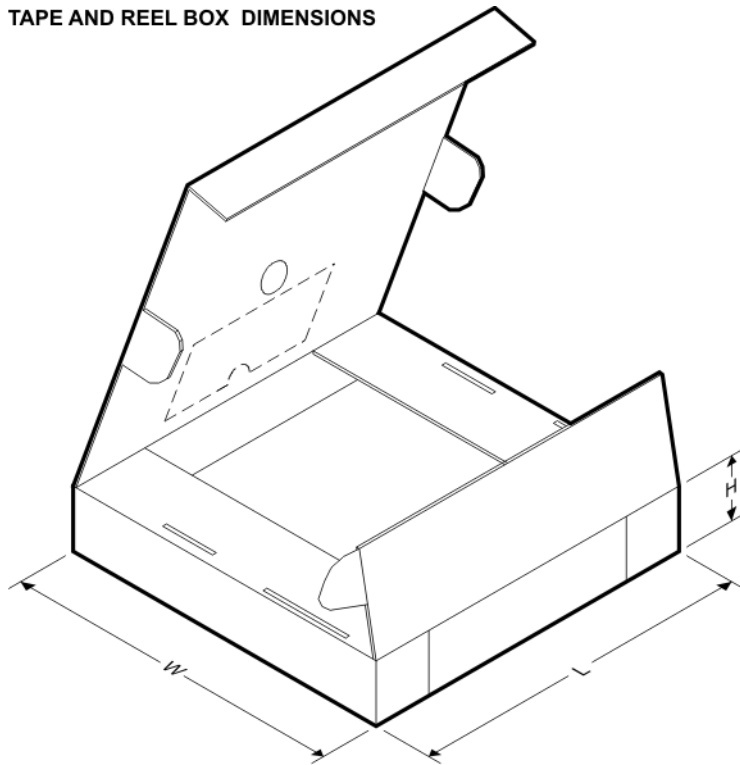
TAPE AND REEL INFORMATION



*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-----------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| SN74GTL1655DGGR | TSSOP | DGG | 64 | 2000 | 330.0 | 24.4 | 8.4 | 17.3 | 1.7 | 12.0 | 24.0 | Q1 |

TAPE AND REEL BOX DIMENSIONS



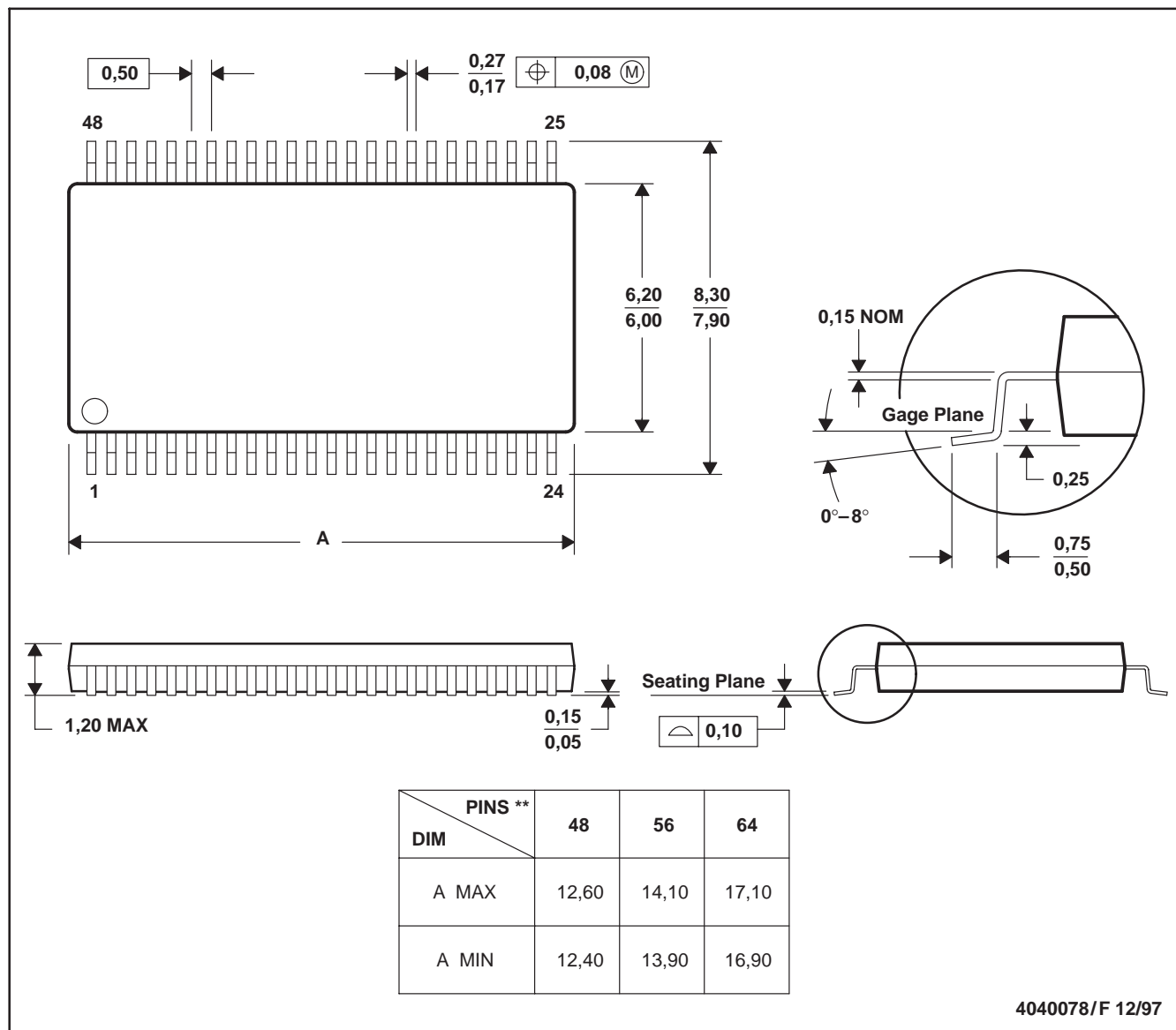
*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|-----------------|--------------|-----------------|------|------|-------------|------------|-------------|
| SN74GTL1655DGGR | TSSOP | DGG | 64 | 2000 | 346.0 | 346.0 | 41.0 |

DGG (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



- NOTES: A. All linear dimensions are in millimeters.
 B. This drawing is subject to change without notice.
 C. Body dimensions do not include mold protrusion not to exceed 0,15.
 D. Falls within JEDEC MO-153

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